

Notice of References Cited

Application/Control No.

10/559,984

Applicant(s)/Patent Under
Reexamination
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Examiner

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Art Unit

2876

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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